

**Search Notes**

Application/Control No.

10/810,721

Examiner

Vincent F. Boccio

Applicant(s)/Patent under  
Reexamination

CHO ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner
<i>See Attached</i>			

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

[illegible]

**Vincent F. Boccio**

2616

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

[illegible]